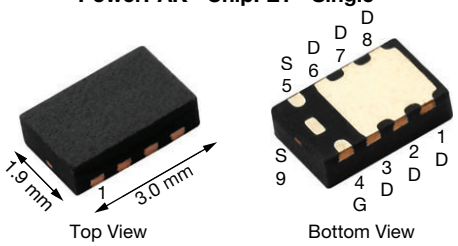
P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY			
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) [a]	Q_g (TYP.)
-20	0.052 at V_{GS} = -4.5 V	-8 [e]	8
	0.082 at V_{GS} = -2.5 V	-7.5	

PowerPAK® ChipFET® Single



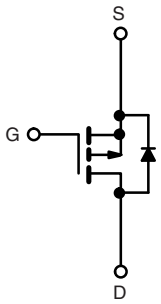
FEATURES

- TrenchFET® power MOSFET
- 100 % R_g tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

Pb-free
RoHS COMPLIANT
HALOGEN FREE

APPLICATIONS

- Load switch
- HDD DC/DC



P-Channel MOSFET

Ordering Information:
Si5459DU-T1-GE3 (Lead (Pb)-free and halogen-free)

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	-20	V
Gate-Source Voltage		V_{GS}	± 12	
Continuous Drain Current (T_J = 150 °C)	T_C = 25 °C	I_D	-8 [e]	A
	T_C = 70 °C		-8 [e]	
	T_A = 25 °C		-6.7 [b, c]	
	T_A = 70 °C		-5.3 [b, c]	
Pulsed Drain Current (10 µs pulse width)		I_{DM}	-20	
Source-Drain Current Diode Current	T_C = 25 °C	I_S	-8 [e]	
	T_A = 25 °C		-2.9 [b, c]	
Maximum Power Dissipation	T_C = 25 °C	P_D	10.9	W
	T_C = 70 °C		7	
	T_A = 25 °C		3.5 [b, c]	
	T_A = 70 °C		2.2 [b, c]	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-50 to 150	°C
Soldering Recommendations (Peak temperature) [d, e]			260	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT		UNIT
			TYPICAL	MAXIMUM	
Maximum Junction-to-Ambient [b, d]	t ≤ 10 s	R_{thJA}	30	36	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	9.5	11.5	

Notes

a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.
c. t = 10 s.
d. Maximum under steady state conditions is 72 °C/W.
e. Package limited.
f. See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
g. Rework conditions: Manual soldering with a soldering iron is not recommended for leadless components.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)						
PARAMETER	**SYMBOL**	**TEST CONDITIONS**	**MIN.**	**TYP. [a]**	**MAX.**	**UNIT**
Static						
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = -250 µA	-20	-	-	V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I_D = -250 µA	-	-19	-	mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$		-	3.1	-	
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = -250 µA	-0.6	-	-1.4	V
Gate-Body Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 12 V	-	-	-100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = -20 V, V_{GS} = 0 V	-	-	-1	µA
		V_{DS} = -20 V, V_{GS} = 0 V, T_J = 55 °C	-	-	-10	
On-State Drain Current [b]	$I_{D(on)}$	V_{DS} = ≤ -5 V, V_{GS} = -10 V	-20	-	-	A
Drain-Source On-State Resistance [b]	$R_{DS(on)}$	V_{GS} = -4.5 V, I_D = -6.7 A	-	0.043	0.052	Ω
		V_{GS} = -2.5 V, I_D = -1 A	-	0.068	0.082	
Forward Transconductance [b]	g_{fs}	V_{DS} = -10 V, I_D = -6.7 A	-	11	-	S
Dynamic [a]						
Input Capacitance	C_{iss}	V_{DS} = -10 V, V_{GS} = 0 V, f = 1 MHz	-	665	-	pF
Output Capacitance	C_{oss}		-	140	-	
Reverse Transfer Capacitance	C_{rss}		-	115	-	
Total Gate Charge	Q_g	V_{DS} = -10 V, V_{GS} = -10 V, I_D = -6.7 A	-	17	26	nC
		V_{DS} = -10 V, V_{GS} = -4.5 V, I_D = -6.7 A	-	8	12	
Gate-Source Charge	Q_{gs}		-	2	-	
Gate-Drain Charge	Q_{gd}		-	3	-	
Gate Resistance	R_g	f = 1 MHz	1.2	6	12	Ω
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = -10 V, R_L = 1.9 Ω I_D ≅ -5.3 A, V_{GEN} = -10 V, R_g = 1 Ω	-	6	12	ns
Rise Time	t_r		-	15	23	
Turn-Off Delay Time	$t_{d(off)}$		-	26	39	
Fall Time	t_f		-	9	18	
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = -10 V, R_L = 1.9 Ω I_D ≅ -5.3 A, V_{GEN} = -4.5 V, R_g = 1 Ω	-	21	32	
Rise Time	t_r		-	50	75	
Turn-Off Delay Time	$t_{d(off)}$		-	29	44	
Fall Time	t_f		-	13	20	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	T_C = 25 °C	-	-	-8	A
Pulse Diode Forward Current [a]	I_{SM}		-	-	-20	
Body Diode Voltage	V_{SD}	I_S = -5.3 A	-	-0.77	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	I_F = -5.3 A, dI/dt = 100 A/µs, T_J = 25 °C	-	30	45	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	17	26	nC
Reverse Recovery Fall Time	t_a		-	16	-	ns
Reverse Recovery Rise Time	t_b		-	14	-	

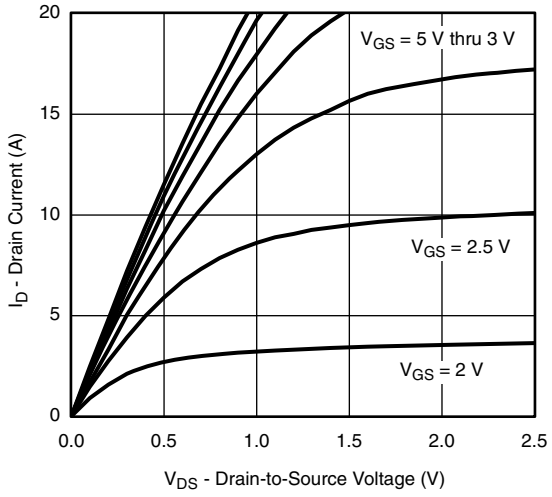
Notes

a. Guaranteed by design, not subject to production testing.

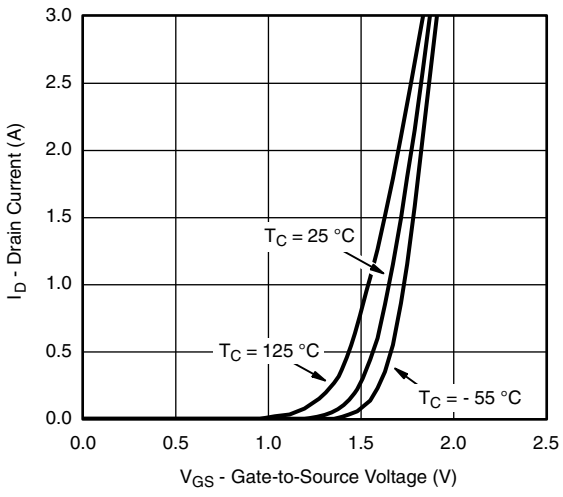
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

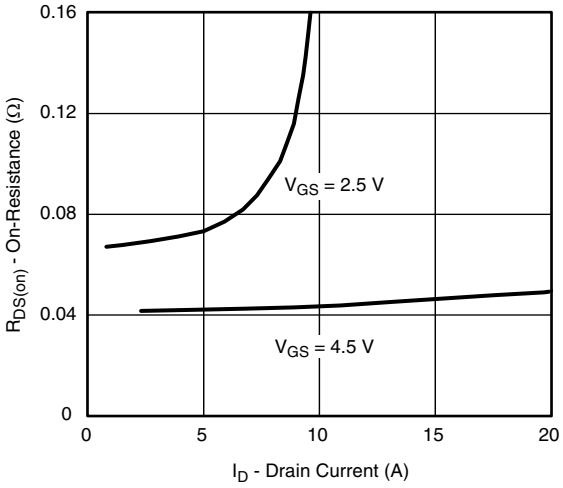
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



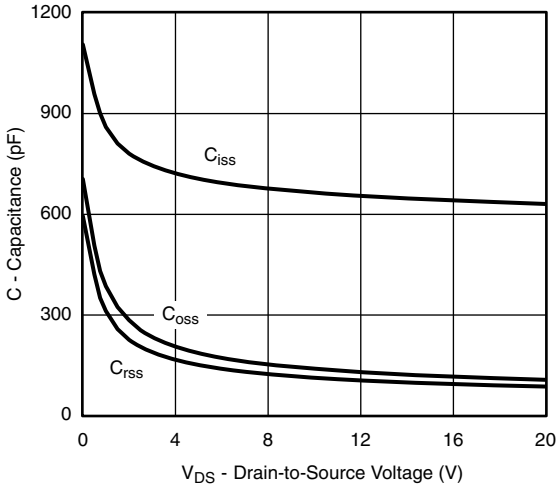
Output Characteristics



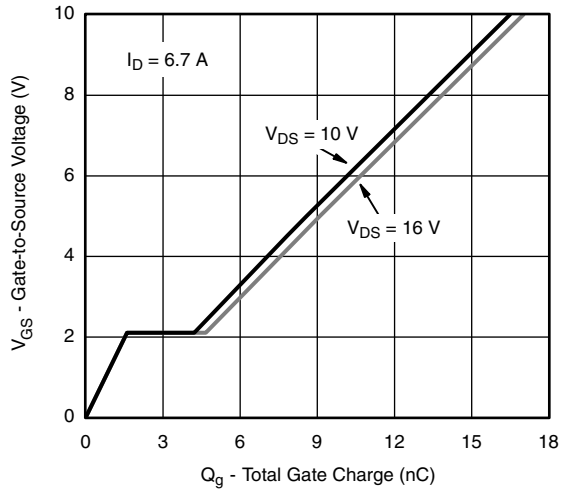
Transfer Characteristics



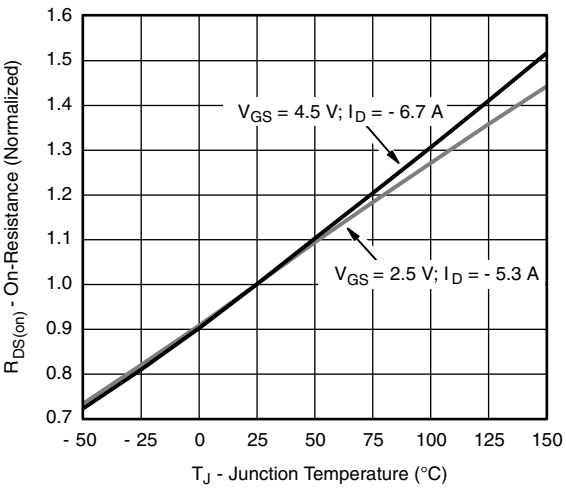
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

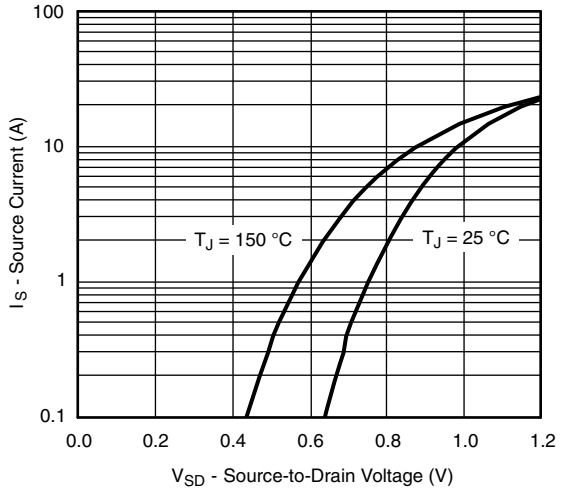


Gate Charge

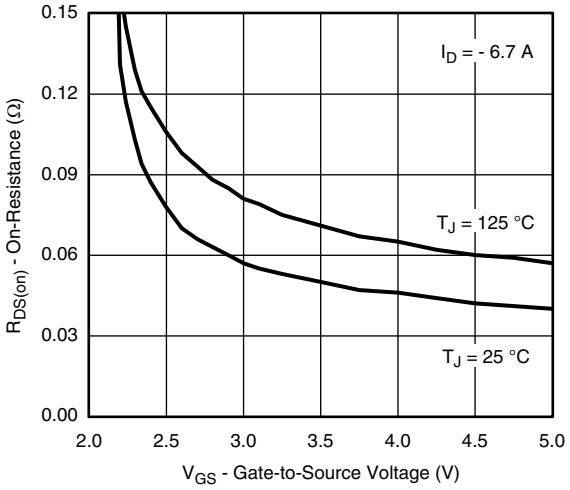


On-Resistance vs. Junction Temperature

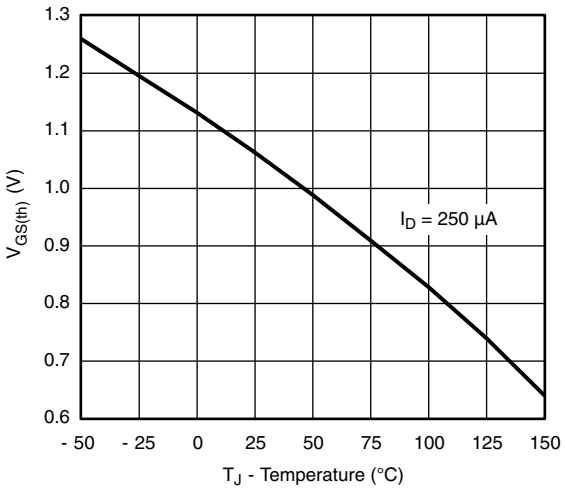
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



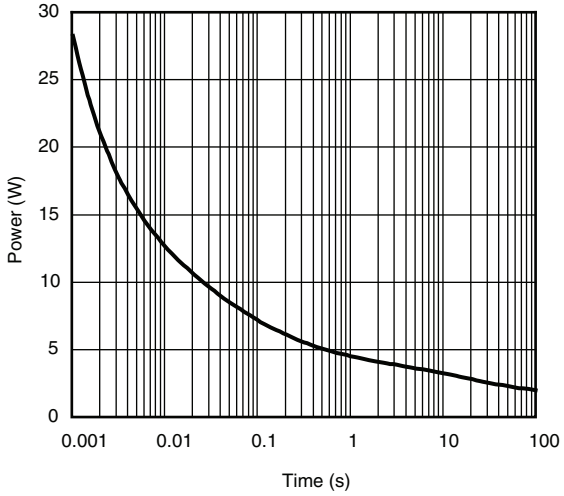
Source-Drain Diode Forward Voltage



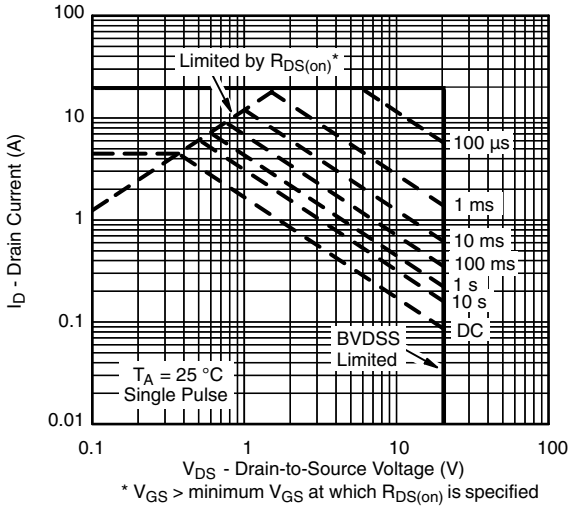
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

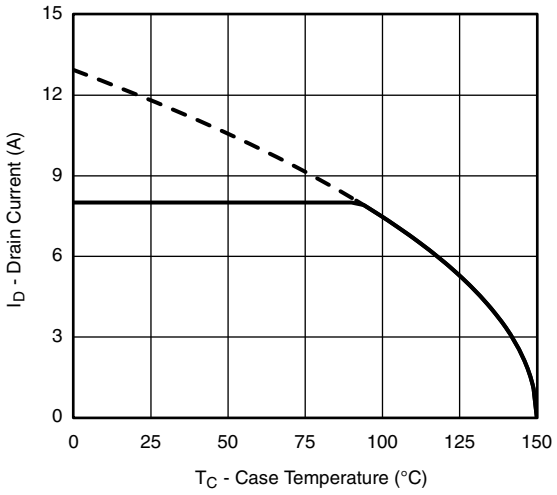


Single Pulse Power, Junction-to-Ambient

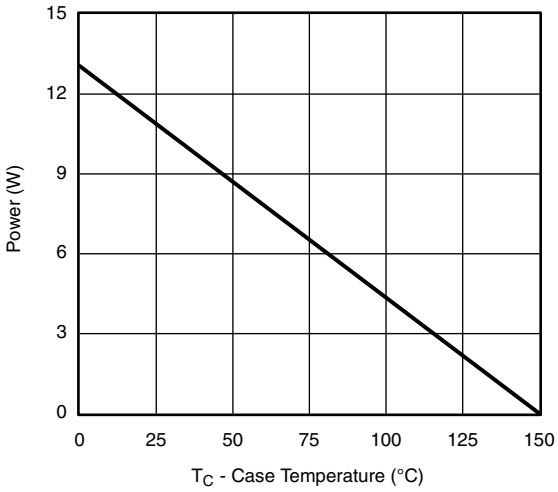


Safe Operating Area, Junction-to-Ambient

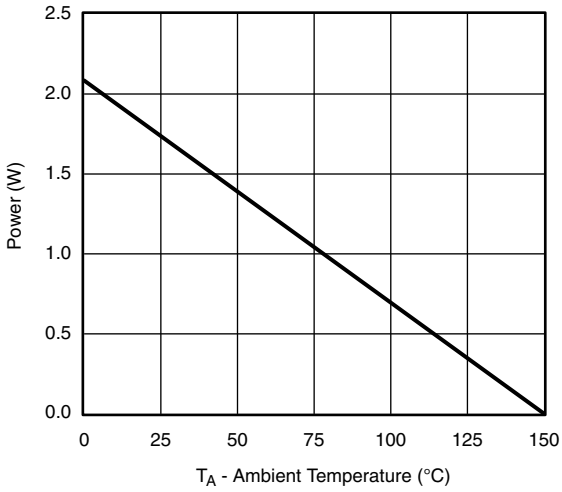
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating [a]



Power Derating, Junction-to-Case

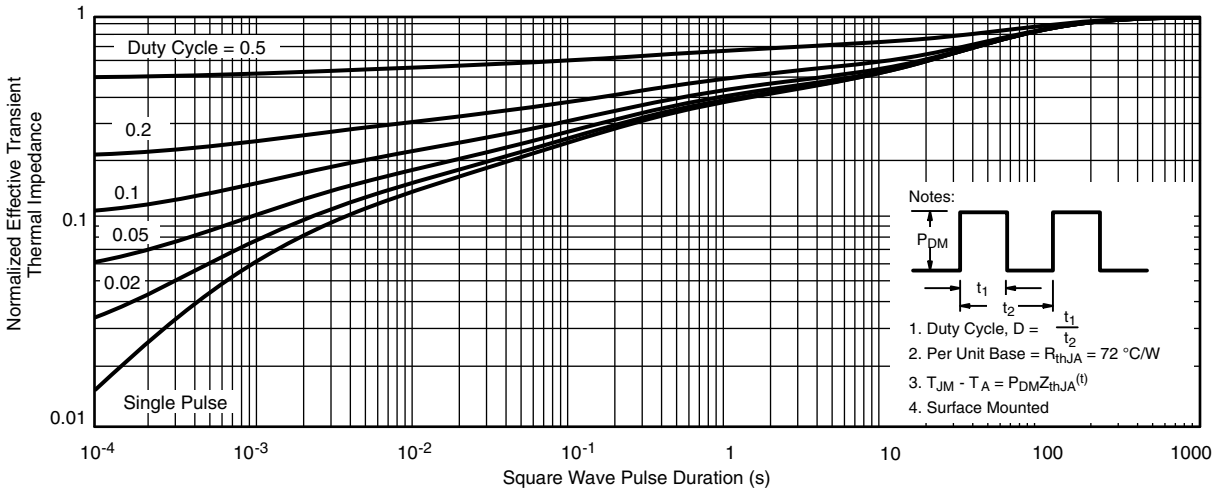


Power Derating, Junction-to-Ambient

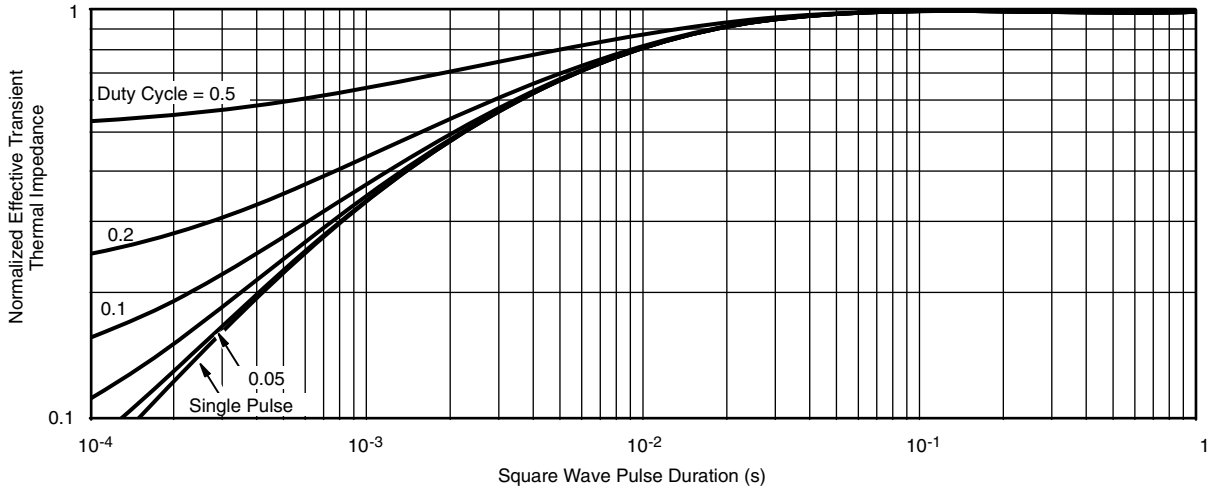
Note

a. The power dissipation P_D is based on $T_{J\,(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



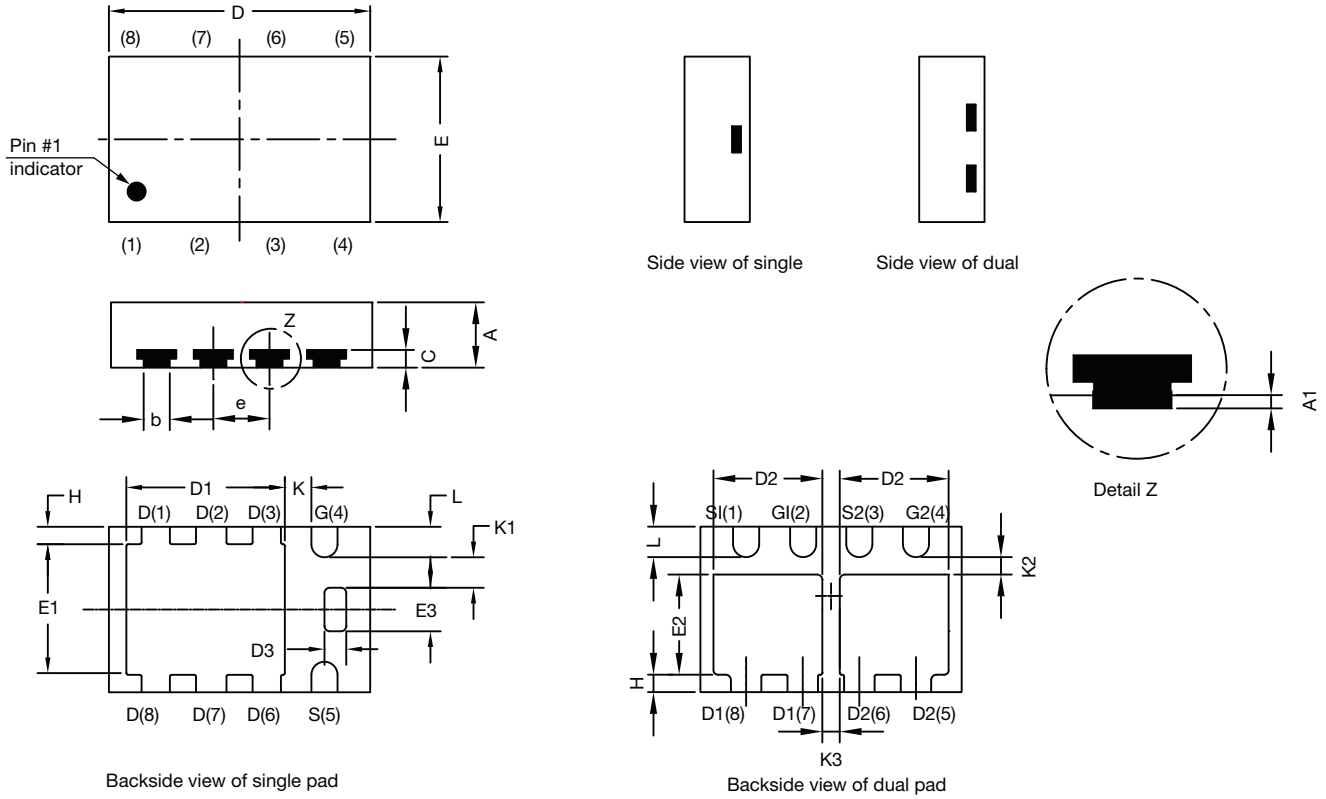
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?65017.

PowerPAK® ChipFET® Case Outline

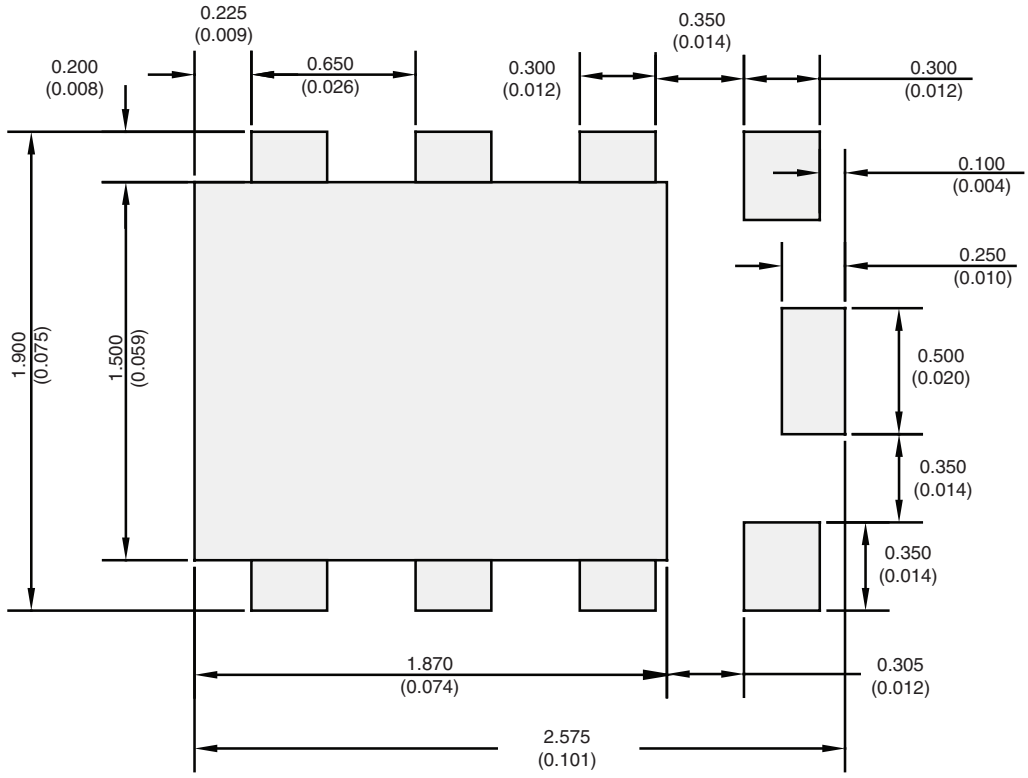


DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.70	0.75	0.85	0.028	0.030	0.033
A1	0	-	0.05	0	-	0.002
b	0.25	0.30	0.35	0.010	0.012	0.014
C	0.15	0.20	0.25	0.006	0.008	0.010
D	2.92	3.00	3.08	0.115	0.118	0.121
D1	1.75	1.87	2.00	0.069	0.074	0.079
D2	1.07	1.20	1.32	0.042	0.047	0.052
D3	0.20	0.25	0.30	0.008	0.010	0.012
E	1.82	1.90	1.98	0.072	0.075	0.078
E1	1.38	1.50	1.63	0.054	0.059	0.064
E2	0.92	1.05	1.17	0.036	0.041	0.046
E3	0.45	0.50	0.55	0.018	0.020	0.022
e	0.65 BSC			0.026 BSC		
H	0.15	0.20	0.25	0.006	0.008	0.010
K	0.25	-	-	0.010	-	-
K1	0.30	-	-	0.012	-	-
K2	0.20	-	-	0.008	-	-
K3	0.20	-	-	0.008	-	-
L	0.30	0.35	0.40	0.012	0.014	0.016
C14-0630-Rev. E, 21-Jul-14 DWG: 5940						

Note

- Millimeters will govern

RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads
Dimensions in mm/(Inches)

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